

Search Notes

Application/Control No.

10/709,890

Examiner

Wen-Ying P. Chen

Applicant(s)/Patent under
Reexamination

LIN ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Review previously cited references	2/22/2006	WPC